

## Article

# Undercooling, Thermal Stability, and Application in Exothermic Catalytic Reaction of SiO<sub>2</sub> Encapsulated SnZnCu Microspheres

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**Abstract:** SiO<sub>2</sub> encapsulated SnZnCu microspheres (several micrometers to about 30 μm in diameter) with very low undercooling, narrow freezing/melting range, and high thermal cycling stability have been produced and used as the temperature stabilizer of the packed bed in highly exothermic Fischer–Tropsch reaction. The core–shell structured SnZnCu@SiO<sub>2</sub> microspheres are prepared in a two-step way, namely SnZnCu microspheres are firstly produced via a molten LiCl–KCl–CsCl eutectic-based metal emulsion method, and then a sol–gel approach is employed to coat them with a uniform, anti-leakage SiO<sub>2</sub> layer. It is found that raising the amount of Zn to 4.0 at.% is critical for achieving a very low undercooling (<5 °C for SnZn<sub>0.04</sub>Cu<sub>x</sub>@SiO<sub>2</sub> vs. about 84 °C for Sn@SiO<sub>2</sub>) and a narrow freezing/melting peak width, and both undercooling and peak width are almost unchanged as the Cu content (*x*) increases from 1.5 to 3.0 at.%. However, their thermal cycling stability depends positively on the amount of Cu and can be remarkably improved when 3.0 at.% Cu is added. The results also show that low undercooling and narrow freezing/melting peak width are associated with the formation of Sn–Zn–Cu ternary eutectic and metastable phase Cu<sub>5</sub>Zn<sub>8</sub>, and poor thermal cycling stability of SnZn<sub>0.04</sub>Cu<sub>x</sub>@SiO<sub>2</sub> microspheres with low Cu content is related to the decomposition of Cu<sub>5</sub>Zn<sub>8</sub> during thermal cycling. By embedding thermally stable SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres into the Co/SiO<sub>2</sub> catalyst for Fischer–Tropsch synthesis, the temperature gradient in the catalyst bed can be significantly reduced by suppressing the formation of hot spots or thermal runaway and thus rapid deactivation of Co catalyst that occurs in the SnZn<sub>0.04</sub>Cu<sub>x</sub>@SiO<sub>2</sub>-absent Co/SiO<sub>2</sub> catalyst can be avoided.

**Keywords:** exothermic reaction; microcapsules; phase change materials; SiO<sub>2</sub>; Sn–Zn–Cu



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## 1. Introduction

Solid–liquid phase change materials (PCMs), a class of materials that can store or release thermal energy during the process of melting or freezing, are widely used in the field of latent heat storage [1–6], e.g., as temperature regulators in building (by coating PCMs into the structure's surfaces or blending PCMs with the construction materials) [1,2] and food storage during transport [5]. A wide range of materials can be used as PCMs, including organics [3] and inorganics (e.g., salts [4] and metals [6]). In comparison with organics or inorganic salts, metal-based PCMs generally have a much higher thermal conductivity which favors rapid thermal energy transfer [4,6], and higher density that allows a high storage density on a volume basis. As a result, liquid metals have found applications in a variety of fields, such as thermal energy storage in a concentrated solar power station [6,7] and chip cooling in USB flash memory [8] or smartphones [9]. However, the direct use of liquid metals as PCMs suffers from significant drawbacks, including the leakage or coalescence of metal droplets during operation and the difficulty in handling them compared to their solid counterparts. To overcome these problems, effectively encapsulating them in chemically stable oxides, e.g., SiO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>, or TiO<sub>2</sub>, to form microcapsules [10] has drawn increasing attention in recent years [11–15].

Like the inorganic salt-based PCMs and encapsulated organic PCMs [16,17], however, one of the main obstacles for practical application of these metal PCMs is their high undercooling [17]. Undercooling, also known as supercooling, is a phenomenon that commonly takes place during the solidification of metal PCMs, where the metal remains liquid until a temperature below the freezing point reaches. This will lead to a reduced solidification temperature and thus the latent heat is released at a lower temperature. As a result, the freezing temperature may not fall within the temperature range controlled by a system and the energy consumption will increase [17]. To fully utilize the latent heat, therefore, a large temperature difference between charging and discharging is needed, which is undesirable for efficient energy storage applications [16]. For instance, the authors are interested in the use of metal-based PCM microparticles for stabilizing the temperature of catalyst bed (embedded in the catalysts or as the core of the catalyst support) in highly exothermic gas–solid catalytic reactions, e.g., Fischer–Tropsch synthesis [18], and an important requirement for this special PCM is that its undercooling should be very small so that the temperature of catalyst bed can be controlled in a narrow range, namely between the endset freezing temperature and the onset melting temperature of PCMs (note: in order to achieve such a goal, a narrow freezing/melting range is also needed). From the practical point of view, therefore, depressing the undercooling lever of metal PCMs is critical for their application in thermal energy storage.

As a non-toxic, low-melting-point (about 231 °C), high-density (about 7.3 g/cm<sup>3</sup>) metal, with a much higher thermal conductivity (about 67 W·m<sup>-1</sup>·K<sup>-1</sup> at 20 °C [19]) compared to the inorganic salts (e.g., the thermal conductivity of commercial molten salts for applications over 200–1000 °C is in the range of 0.515–0.586 W·m<sup>-1</sup>·K<sup>-1</sup> [4]), Sn microparticles encapsulated in chemically stable oxides should be potential phase change material (PCM) for latent heat storage [13,15]. For example, they might serve as substitutes for nitrate-based PCMs in thermal energy storage due to having a melting point close to some of nitrate eutectic salts-based PCMs [4] or a potential candidate for temperature stabilizer of the catalyst bed in low-temperature (220–240 °C) Fischer–Tropsch synthesis because of their melting point matches well with the reaction temperature. However, an extremely high undercooling required for the occurrence of liquid–solid phase transition is normally observed for small-sized Sn. For example, the undercooling of single Sn microparticles is size-dependent and their undercooling rises from 50 °C to about 95 °C when their size decreases from about 640 to 460 μm [20]. For SiO<sub>2</sub> encapsulated Sn microspheres of about 40 μm in diameter, undercooling of about 76 °C can be found in Bao's work [13]. A similar result can be observed for Al<sub>2</sub>O<sub>3</sub> microencapsulated Sn particles in Zhu's work [15]. The very high undercooling of micro-sized Sn greatly restricts their practical application as PCMs. Fortunately, although no work on the undercooling suppression of microencapsulated Sn-based PCMs can be found in the literature, reducing the undercooling of bulk Sn by doping traces of elements has been well studied in the past [21–23] thanks to the fact that Sn is a dominant component of Pb-free solders. For example, the introduction of both Cu (1.1–1.7 at.%) and another non-noble metal, such as Co (1.2–1.7 at.%) [23], Ni (0.3–0.7 at.%) [22], or Zn (1.1 at.%) [23], into Sn is found to be an extremely effective way to depress the undercooling of Sn-based solders. For example, an undercooling of 6.8 °C was reported in SnCu<sub>0.017</sub>Zn<sub>0.011</sub> solders [23]. Unfortunately, when preparing Cu and Zn-doped Sn microcapsules of very low undercooling and narrow freezing/melting range so that they can serve as temperature stabilizer of the catalyst bed in Fischer–Tropsch synthesis, problems arise. (i) Probably due to the size effect, doping with the same amounts of Cu and Zn (namely 1.7 at.% Cu and 1.1 at.% Zn) is much less effective for reducing the undercooling of Sn microparticles (diameter ranging from several micrometers to about 30 μm) [24] compared to the result observed in Sn-based solders [23]. Furthermore, a very broad freezing peak is often observed in these microencapsulated Sn-based microparticles [24] and thus a lower temperature is needed for totally releasing the latent heat, which is unfavorable for their practical application. In particular, the key factors responsible for the undercooling suppression in Cu and Zn-doped Sn microcapsules are still unknown.

(ii) While the thermal cycling stability of Sn-based solders is normally not studied, it is a very important property of PCMs for their long-term application. However, up to now, there is no work on the thermal cycling stability of microencapsulated Sn-based multi-component PCMs, especially the factors governing the thermal cycling stability. From a practical point of view, therefore, solving these problems to obtain microencapsulated Sn-based PCMs with very low undercooling, narrow freezing/melting range, and high thermal cycling stability is of great importance.

In this article, a study on the synthesis, phase change properties, thermal cycling stability, and application in exothermic catalytic reactions of SiO<sub>2</sub> encapsulated SnZnCu microspheres is presented. By doping with high amounts of both Zn (3–5 at.%) and Cu (1.5–4 at.%) into Sn microspheres, the goal of this work is to find a type of SiO<sub>2</sub> microencapsulated SnZnCu microspheres (several micrometers to about 30 μm in diameter) that meets the above three requirements for use as the temperature stabilizer of the packed bed in highly exothermic Fischer–Tropsch reaction and unveil the factors responsible for undercooling suppression and thermal stability enhancement. The content of this work mainly includes four aspects. (i) Prepare SnZnCu microspheres via a molten LiCl–KCl–CsCl eutectic-based metal emulsion method [24] and coat them with a uniform, anti-leakage SiO<sub>2</sub> layer by a sol–gel approach [25]. (ii) Examine the effect of Cu and Zn addition on the phase composition and phase change properties of SnZnCu@SiO<sub>2</sub> microspheres. (iii) Study the thermal cycling stability of SnZnCu@SiO<sub>2</sub> microspheres and gain an insight into the factors governing the thermal stability. (iv) Embed the SnZnCu@SiO<sub>2</sub> microspheres with desired properties into the Co/SiO<sub>2</sub> catalyst for Fischer–Tropsch synthesis and evaluate the effect of the presence of PCM on the temperature of the catalyst bed.

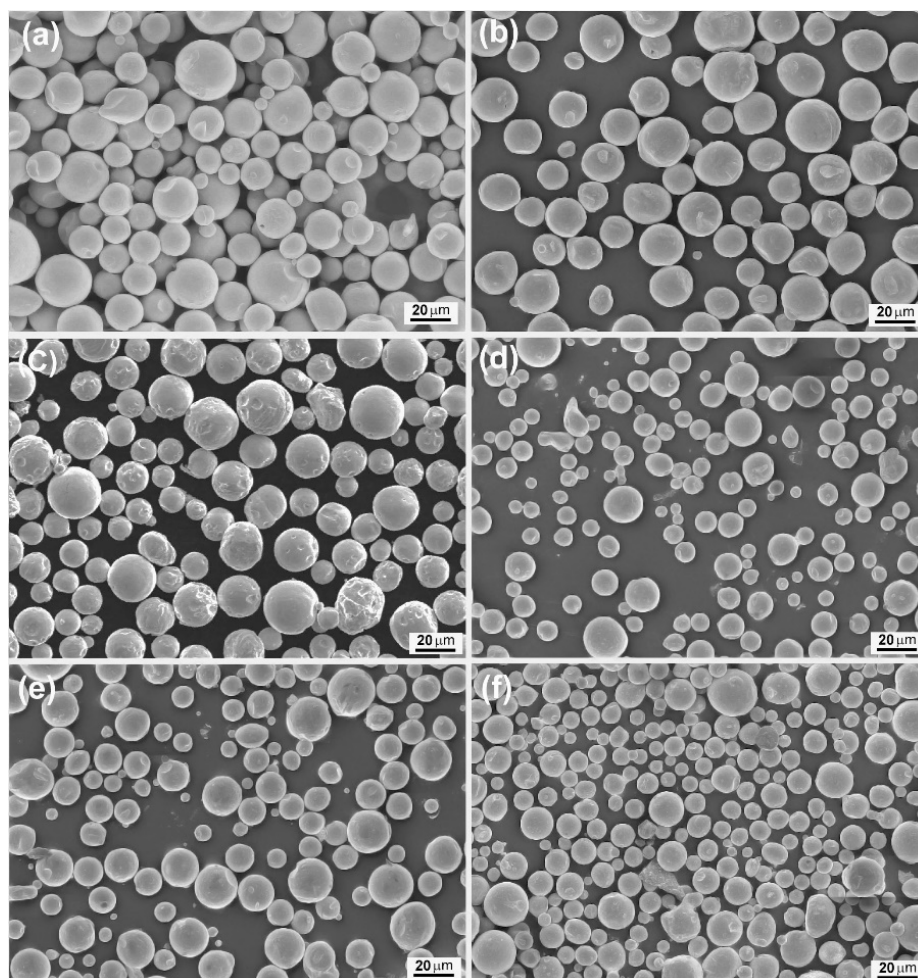
## 2. Results and Discussion

### 2.1. Preparation and SiO<sub>2</sub> Encapsulation of SnZnCu Microspheres

The SnZnCu microspheres were prepared by a molten LiCl–KCl–CsCl eutectic-based metal emulsion method [24]. Since the melting points of bulk Cu are about 1080 °C, in the previous work, an annealing temperature of 1000 °C was chosen to melt micro-sized Cu powder [24]. In this work, Cu powder was replaced by Cu nanowires. As shown in Figure S1 (see Supplementary Materials), Cu nanowires with an average diameter of about 120 nm have an initial melting temperature of about 500 °C, and at 700 °C all Cu nanowires, whether their diameters are large or small, are melted. Therefore, an annealing temperature of 750 °C was used to melt Cu nanowires. Figure 1 presents the SEM images of some SnZnCu samples (namely SnZn<sub>0.04</sub>Cu<sub>0.015</sub>, SnZn<sub>0.04</sub>Cu<sub>0.02</sub>, and SnZn<sub>0.04</sub>Cu<sub>0.03</sub>) prepared by the molten salt-based metal emulsion method. For the sake of comparison, the SEM images of Sn, SnCu<sub>0.015</sub>, and SnZn<sub>0.04</sub> are also shown. It is obvious from these SEM images that all the products of different chemical compositions are dominantly composed of spherical microparticles, and the diameters of these microspheres are typically in the range of several micrometers to more than twenty micrometers under the employed experimental conditions. Since the metal microspheres originate from rapid solidification of the metal droplets in the molten salts, this result suggests that the Sn-based liquid metal can be ultrasonically emulsified into the molten LiCl–KCl–CsCl eutectic as micro-sized droplets, and such molten salt-based metal emulsion method is an effective way for preparing well-shaped SnZnCu microspheres.

Encapsulation of SnZnCu microspheres in SiO<sub>2</sub> is achieved by a sol–gel method [25]. Figure 2 presents the SEM, TEM, and scanning transmission electron microscopy (STEM) images of SnZn<sub>0.04</sub>Cu<sub>0.015</sub> after being encapsulated in SiO<sub>2</sub>. It is clear from the TEM and STEM images that these metal microspheres are coated with a uniform layer of SiO<sub>2</sub> whose thickness is about 260 nm under the employed experimental conditions. In addition, the thickness of the SiO<sub>2</sub> layer can be easily raised by simply repeating the encapsulation procedure. As shown in Figure 3, the thickness of the SiO<sub>2</sub> layer can be raised to more than 700 nm or 1 micrometer after repeating encapsulation three or five times. These results suggest that this sol–gel method is extremely effective for coating SnZnCu microspheres

with a uniform  $\text{SiO}_2$  layer of desired thickness. In order to ensure the practical application of  $\text{SiO}_2$ -encapsulated SnZnCu microspheres as PCMs for latent heat storage, the  $\text{SiO}_2$  layer should have the ability to prevent the leakage of liquid metal cores during operation. The anti-leakage experiment is conducted at  $400\text{ }^\circ\text{C}$ , a temperature well above the melting point of SnZnCu microspheres. Since the metals might form a thin layer of oxide that may help to prevent their leakage if the microspheres are tested in air at  $400\text{ }^\circ\text{C}$ , the anti-leakage of the  $\text{SiO}_2$  layer is evaluated in the atmosphere of  $\text{N}_2$ . Figure 4 presents the SEM images of  $\text{SiO}_2$ -encapsulated  $\text{SnZn}_{0.04}\text{Cu}_{0.015}$  microsphere (encapsulation times = 3) before and after calcination at  $400\text{ }^\circ\text{C}$  in  $\text{N}_2$  for 6 h. No obvious change in the morphology of these microcapsules can be observed before and after calcination, indicating that the  $\text{SiO}_2$  layer as the shell of SnZnCu microcapsules can prevent the leakage of liquid metals during operation.

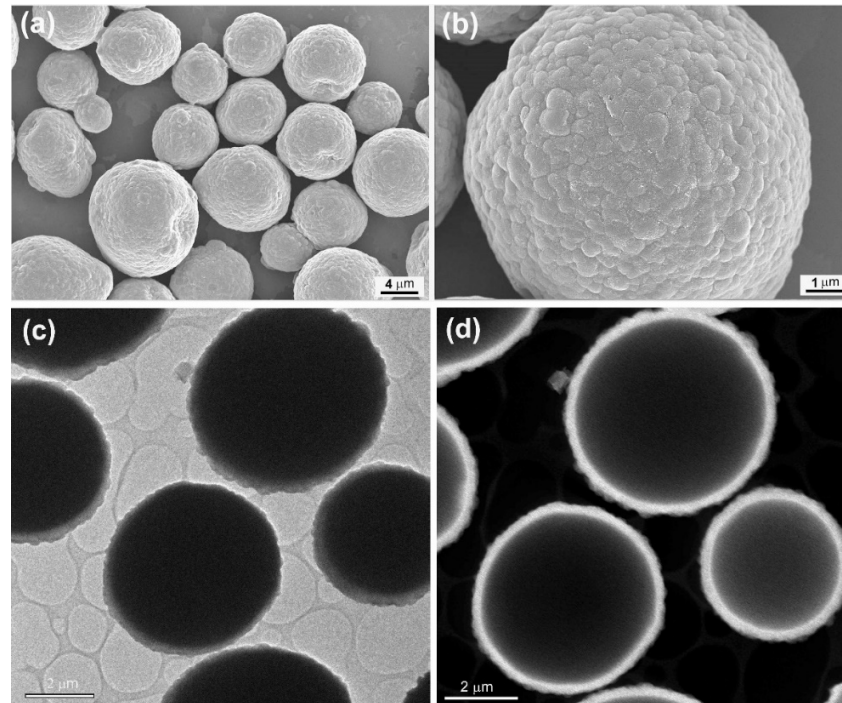


**Figure 1.** SEM images of metal microspheres of different chemical compositions prepared via a molten salt-based metal emulsion method: (a) Sn, (b)  $\text{SnCu}_{0.015}$ , (c)  $\text{SnZn}_{0.04}$ , (d)  $\text{SnZn}_{0.04}\text{Cu}_{0.015}$ , and (e)  $\text{SnZn}_{0.04}\text{Cu}_{0.02}$  and (f)  $\text{SnZn}_{0.04}\text{Cu}_{0.03}$ .

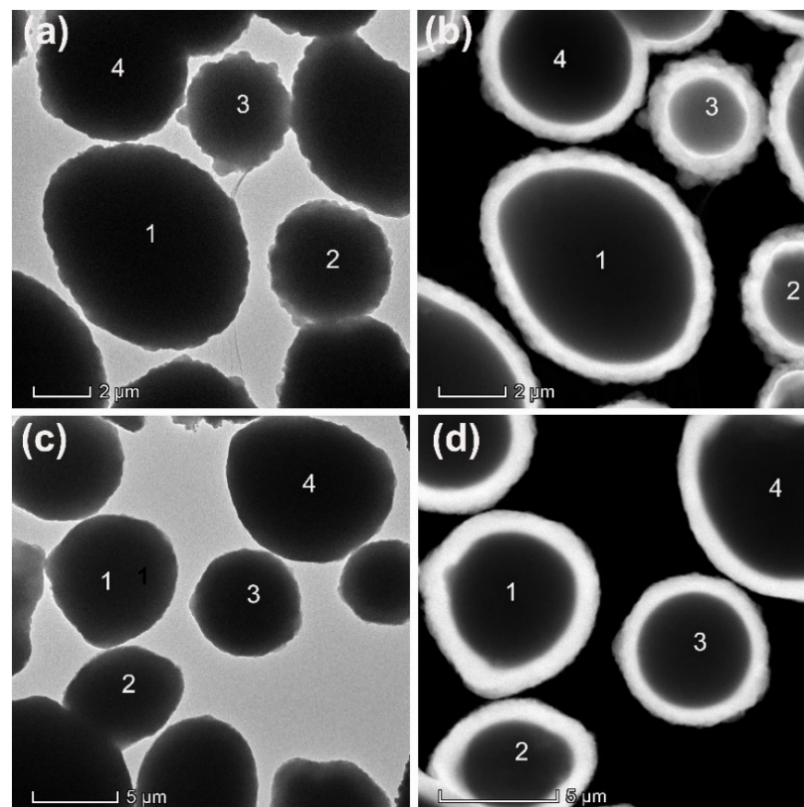
## 2.2. Effect of Addition of Cu and Zn on Both Phase Composition of Sn Microspheres and the Undercooling of Sn Microcapsules

Thermodynamically, undercooling is an inherent feature of liquid to solid phase transition via homogeneous nucleation. Unlike heterogeneous nucleation which starts at nucleation sites on surfaces or pre-existing nuclei in the old phase, homogeneous nucleation needs the creation of new nuclei of very small size that are thermodynamically unstable and thus requires the undercooling of the medium. Doping of Sn with trace elements may introduce new clusters as nucleation sites or new phases whose surface can provide

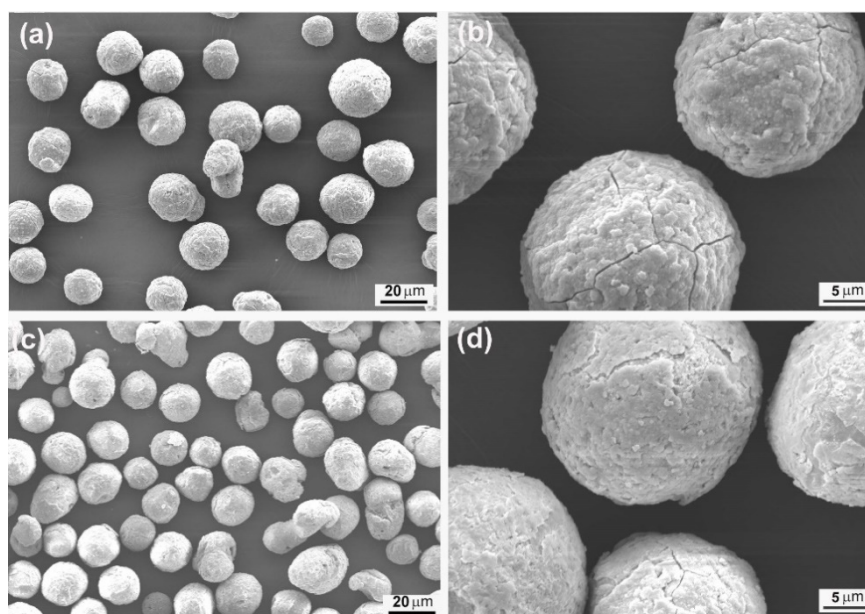
nucleation sites to induce heterogeneous nucleation and thus reduce the undercooling. Therefore, understanding the phase composition of doped Sn will help to identify which phase can provide more effective nucleation sites for heterogeneous nucleation.



**Figure 2.** SEM, TEM, and STEM images of SiO<sub>2</sub>-encapsulated SnZn<sub>0.04</sub>Cu<sub>0.015</sub> microspheres via an interface-confined sol-gel method: (a,b) SEM, (c) TEM, and (d) STEM.



**Figure 3.** TEM and STEM images of SiO<sub>2</sub>-encapsulated SnZn<sub>0.04</sub>Cu<sub>0.015</sub> microspheres obtained via the interface-confined sol-gel method with different encapsulation times: (a,b) 3 and (c,d) 5.

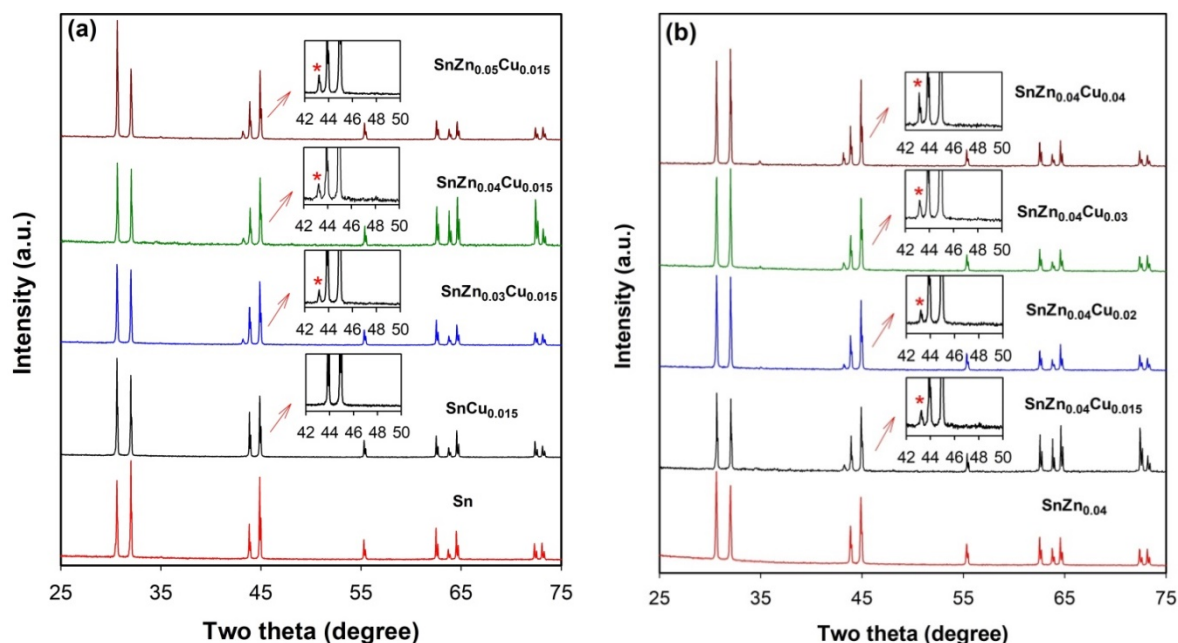


**Figure 4.** SEM images of SiO<sub>2</sub>-encapsulated SnZn<sub>0.04</sub>Cu<sub>0.015</sub> microspheres (encapsulation times = 3) before (a,b) and after calcination (c,d) at 400 °C in N<sub>2</sub> for 6 h.

Figure 5 presents the XRD patterns of as-prepared SnZnCu microspheres with different amounts of Zn (Figure 5a) or different amounts of Cu (Figure 5b). For comparison, the XRD patterns of Sn, SnCu<sub>0.015</sub>, and SnZn<sub>0.04</sub> are also shown. For all microspheres, the peaks observed at  $2\theta$  of 30.6°, 32.0°, 43.9°, 44.9°, 55.4°, 62.5°, 63.8°, 64.6°, 72.4°, and 73.1° can all be indexed to metal Sn with a tetragonal structure (space group I41/amd, JCPDS 04-0673) and correspond to the diffractions of (200), (101), (220), (211), (301), (112), (400), (321), (420), and (411) planes, respectively. The absence of the diffraction peaks of Sn oxides, Cu oxides, or Zn oxides indicates that the Ar gas protection can avoid the oxidation of metal droplets during ultrasonic emulsification. In the XRD patterns of SnCu<sub>0.015</sub> microspheres (Figure 5a), no peaks which can be attributed to Cu or Sn–Cu intermetallic compounds can be observed. A similar phenomenon can be found in the XRD patterns of SnZn<sub>0.04</sub> microspheres where no diffraction peaks of Zn appear (Figure 5b). According to the phase diagrams of Sn–Cu [26] and Sn–Zn [27], there is a eutectic reaction  $L = \text{Cu}_6\text{Sn}_5 + \text{Sn}$  at 1.66 at.% Cu and a temperature of 227 °C in the Sn–Cu system and a eutectic reaction  $L = \text{Zn} + \text{Sn}$  at about 14.9 at.% Zn and 199 °C in the Sn–Zn system. Hence, at a low solidification rate, Cu<sub>6</sub>Sn<sub>5</sub> or Zn phase should be observed when the temperature of the system reaches room temperature. No Cu<sub>6</sub>Sn<sub>5</sub> or Zn phase observed in SnCu<sub>0.015</sub> or SnZn<sub>0.04</sub> microspheres indicate that Cu or Zn is highly dispersed in the Sn matrix due to rapid cooling.

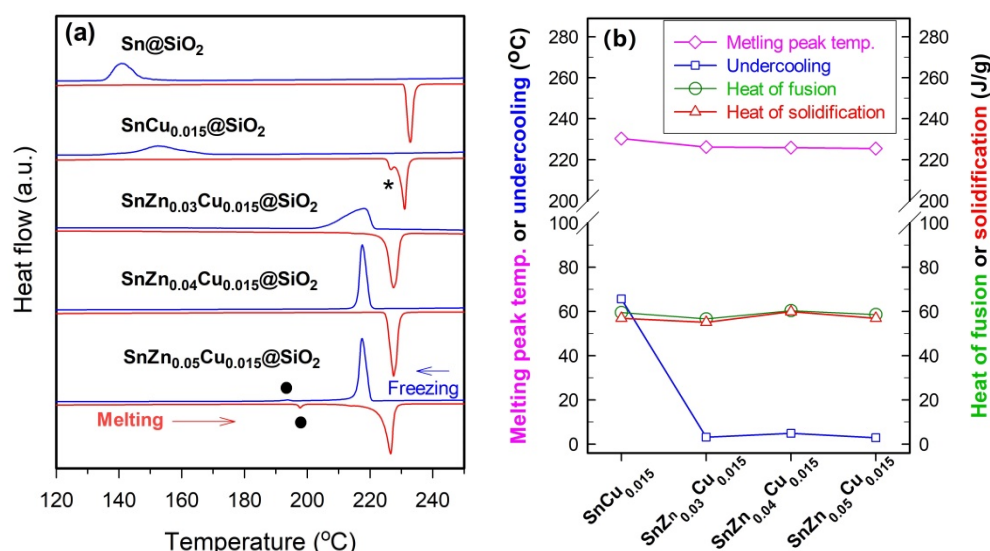
Owing to the much lower solubility of Cu in Sn compared to that of Zn in Sn at a temperature close to the melting point of Sn [26,27], however, new peaks appear in the XRD patterns of SnCu microspheres when the amount of Cu is raised to 3.0 at.% (Figure S2). These peaks at  $2\theta$  of 30.1°, 42.3°, and 43.3° can be attributed to the diffractions of (22-1), (132), and (42-2) of the intermetallic compound Cu<sub>6</sub>Sn<sub>5</sub> with a monoclinic structure (space group C2/c, JCPDS 45-1488). The formation of the Cu<sub>6</sub>Sn<sub>5</sub> phase, rather than the Cu phase, is consistent with the result obtained from the Sn–Cu phase diagram for a system containing small amounts of Cu [26]. However, such an intermetallic phase cannot be found when both Zn and Cu are added to Sn, e.g., 3.0–5.0 at.% of Zn is added into SnCu<sub>0.015</sub> (see Figure 5a) or 1.5–4.0 at.% of Cu is added into SnZn<sub>0.04</sub> (see Figure 5b). Instead, a new peak at  $2\theta$  of about 43.2° appears in the XRD patterns of these SnZnCu microspheres. Since this peak is absent in the XRD patterns of SnCu<sub>0.015</sub>, SnCu<sub>0.02</sub>, SnCu<sub>0.03</sub>, and SnZn<sub>0.04</sub> microspheres, it is speculated that this peak should be related to the formation of another intermetallic phase Cu<sub>5</sub>Zn<sub>8</sub> with a cubic structure and correspond to the diffraction of (330) plane (JCPDS 41-1435). This Cu<sub>5</sub>Zn<sub>8</sub> phase has been reported to be formed via an interfacial reaction

between the Sn–Zn solders and Cu substrate [28] or by melting Cu and Zn powders in an electric arc discharge synthesis [29]. In fact, the  $\text{Cu}_5\text{Zn}_8$  phase is an equilibrium phase for a system containing 3.0–5.0 at.% of Zn and 1.5 at.% of Cu at room temperature based on the isothermal sections of the Sn–Zn–Cu system at 210 °C [30]. The formation of the  $\text{Cu}_5\text{Zn}_8$  phase in SnZnCu microspheres demonstrates that Cu atoms are preferentially segregated to Zn atoms, rather than Sn atoms. As will be shown below, the presence of the  $\text{Cu}_5\text{Zn}_8$  phase is much more effective than the  $\text{Cu}_6\text{Sn}_5$  phase for inducing heterogeneous nucleation that may significantly reduce the undercooling.



**Figure 5.** XRD patterns of SnZnCu microspheres with different amounts of Zn (a) and different amounts of Cu (b). XRD patterns of Sn,  $\text{SnCu}_{0.015}$ , and  $\text{SnZn}_{0.04}$  microspheres are also shown for comparison.

The undercooling in this work is defined as the difference between the onset temperatures of melting ( $T_{\text{onset,m}}$ ) and solidification ( $T_{\text{onset,s}}$ ) in DSC measurement [20,21,23]. The value of the onset temperature of melting or solidification was determined by the intersection of the heat flow curve with the baseline during the melting or solidification process. As shown in Figure 6a, the onset temperature of solidification of Sn in  $\text{Sn@SiO}_2$  microspheres is about 147.0 °C and the undercooling obtained is around 83.7 °C. The very high undercooling observed for  $\text{Sn@SiO}_2$  microspheres indicates that the homogenous nucleation dominates in the Sn solidification process despite the presence of  $\text{SiO}_2$  shell. Although the addition of small amounts of Cu (1.5 at.%) may facilitate the solidification of Sn and thus  $\text{SnCu}_{0.015}\text{@SiO}_2$  microspheres have a lower undercooling (about 57 °C) compared to  $\text{Sn@SiO}_2$  microspheres (Figure 6b), the resulting undercooling is still too high for practical application. In addition, a very broad freezing peak is observed in  $\text{SnCu}_{0.015}\text{@SiO}_2$  microspheres. Since under the same experimental conditions, a wider melting/freezing peak implies a broader melting/freezing range despite that the value of the peak width depends on the heating/cooling rate and the mass of the sample measured, the broad freezing peak suggests a wide temperature range needed for totally releasing the latent heat. This phenomenon also exists in  $\text{SnCu}_{0.02}\text{@SiO}_2$  or  $\text{SnCu}_{0.03}\text{@SiO}_2$  microspheres with the presence of the  $\text{Cu}_6\text{Sn}_5$  phase (Figure S3 in Supplementary Materials). These results hint that the  $\text{Cu}_6\text{Sn}_5$  phase cannot provide very effective sites for rapid nucleation and solidification of liquid Sn.



**Figure 6.** DSC curves (a) and phase change properties (b) of SiO<sub>2</sub>-encapsulated SnZnCu (encapsulation times = 1) of different amounts of Zn. The results obtained from Sn@SiO<sub>2</sub> and SnCu<sub>0.015</sub>@SiO<sub>2</sub> microspheres are also shown for comparison.

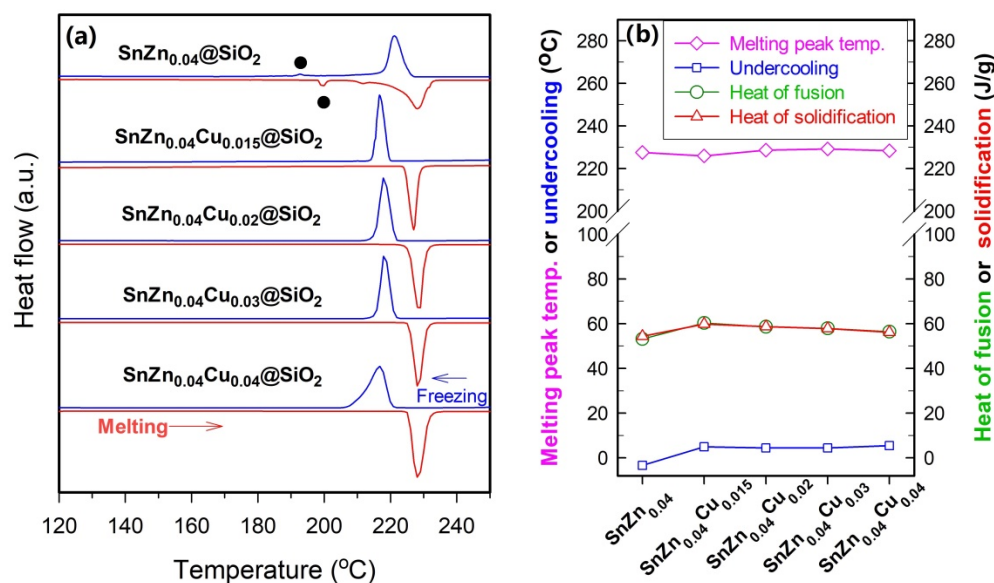
To further reduce the undercooling and narrow the freezing range, 3.0–5.0 at.% of Zn, which is much higher than 1.1 at.% used in Sn-based solders, is introduced into SnCu<sub>0.015</sub>@SiO<sub>2</sub> microspheres (Figure 6). The addition of 3.0–5.0 at.% Zn can significantly reduce undercooling. For example, the values of undercooling of SnZn<sub>0.03</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub>, SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub>, and SnZn<sub>0.05</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres are about 3.2, 4.9, and 2.8 °C, respectively. Furthermore, the exothermic peak of SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> or SnZn<sub>0.05</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres is much sharper than that of Sn@SiO<sub>2</sub> or SnCu<sub>0.015</sub>@SiO<sub>2</sub> microspheres, suggesting that addition of 4.0 or 5.0 at.% Zn can greatly reduce the freezing range. As indicated by the difference in phase composition between SnCu<sub>0.015</sub>@SiO<sub>2</sub> and SnZn<sub>0.03–0.05</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres (Figure 5a), the significant promotion effect on the solidification of liquid Sn observed in these SnZnCu@SiO<sub>2</sub> microspheres should be related to the formation of the Cu<sub>5</sub>Zn<sub>8</sub> phase. In addition, by comparing these observations with the result obtained from SnCu<sub>0.03</sub>@SiO<sub>2</sub> microspheres in the presence of Cu<sub>6</sub>Sn<sub>5</sub> phase, it is inferred that the Cu<sub>5</sub>Zn<sub>8</sub> phase can provide much more effective sites for heterogeneous nucleation than the Cu<sub>6</sub>Sn<sub>5</sub> phase. This result is similar to the observation in Sn–Cu–Ni solders that the Ni<sub>3</sub>Sn<sub>4</sub> phase is more effective for undercooling suppression than the Cu<sub>6</sub>Sn<sub>5</sub> phase [22].

Besides reducing the undercooling and narrowing the freezing range, the addition of 4.0 at.% Zn also results in a sharp, symmetrical melting peak with its peak temperature being slightly lower than that of Sn@SiO<sub>2</sub> microspheres (Figure 6a). The sharp melting peak hints at a very narrow melting range, which is a common feature of a pure substance or a eutectic mixture, hinting that Sn–Zn–Cu eutectic forms in SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres probably because the chemical composition of SnZn<sub>0.04</sub>Cu<sub>0.015</sub> microspheres is close to that of Sn–Zn–Cu eutectic. According to the method for determination of eutectic by DSC [31], the speculation that the addition of 4 at.% Zn leads to a chemical composition close to the composition of Sn–Zn–Cu eutectic is supported by the result that when 3.0 or 5.0 at.% Zn is added, the melting peak is obviously broader than that of SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres (Figure 6a). In addition, when 5.0 at.% Zn is added, a pair of new but weak peaks appear in the melting and solidification processes (indicated by solid circles in Figure 6a), indicating that 5.0 at.% Zn is obviously larger than the amount of Zn in the Sn–Zn–Cu eutectic. Based on the Sn–Zn phase diagram [27], an endothermic peak temperature of around 197 °C hints at the formation of SnZn<sub>0.15</sub> eutectic in SnZn<sub>0.05</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres. It is also interesting to note that the chemical composition of SnZn<sub>0.04</sub>Cu<sub>0.015</sub> microspheres is



very similar to that of another Sn-based ternary eutectic, namely Sn–Ag–Cu eutectic with 3.5 wt.% Ag and 0.9 wt.% Cu (namely about 3.81 at.% Ag and 1.66 at.% Cu) [32].

The above results demonstrate that addition of 4.0 at.% Zn is crucial for achieving a type of SnZnCu@SiO<sub>2</sub> microsphere (namely SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microsphere) with very low undercooling and narrow freezing/melting peak width via the formation of both Sn–Zn–Cu ternary eutectic and intermetallic phase Cu<sub>5</sub>Zn<sub>8</sub>. In order to further understand the effect of Cu amount on the phase change properties of SnZnCu@SiO<sub>2</sub> microspheres, the amount of Cu is raised from 1.5 to 4.0 at.% (Figure 7). In the absence of Cu, the primary endothermic peak of SnZn<sub>0.04</sub>@SiO<sub>2</sub> microspheres is broad and asymmetrical, and a pair of weak peaks appear in the melting and solidification processes (indicated by solid circles in Figure 7a), hinting at the formation of a small amount of SnZn<sub>0.15</sub> eutectic. Based on the Sn–Zn phase diagram [27], the observed broad and asymmetrical endothermic peak is consistent with the fact that its chemical composition greatly deviates from that of Sn–Zn eutectic and is the reason for a negative value (−3.41 °C) of undercooling obtained in SnZn<sub>0.04</sub>@SiO<sub>2</sub> microspheres. It is interesting to find that raising the amount of Cu from 1.5 at.% to 2.0 or 3.0 at.% has no significant impact on both the undercooling and the freezing/melting peak width, and all three types of SnZnCu@SiO<sub>2</sub> microspheres, namely SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub>, SnZn<sub>0.04</sub>Cu<sub>0.02</sub>@SiO<sub>2</sub>, and SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres, own a very low undercooling and sharp freezing/melting peaks. However, when the amount of Cu is raised to 4.0 at.%, both the melting peak and the freezing peak become broader compared to those of SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres, suggesting that the chemical composition has obviously deviated from that of Sn–Zn–Cu ternary eutectic.

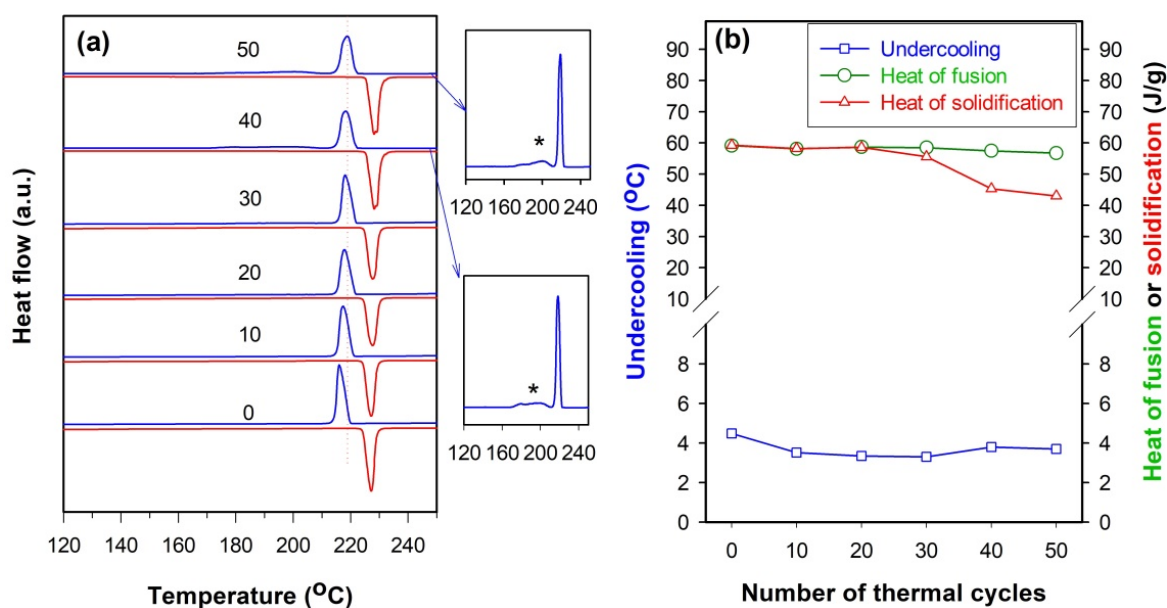


**Figure 7.** DSC curves (a) and phase change properties (b) of SiO<sub>2</sub>-encapsulated SnZnCu (encapsulation times = 1) of different amounts of Cu. The result obtained from SnZn<sub>0.04</sub>@SiO<sub>2</sub> microspheres is also shown for comparison.

### 2.3. Thermal Cycling Stability of SnZnCu@SiO<sub>2</sub> Microspheres and the Factors Governing Thermal Stability

The understanding of the thermal cycling stability of SnZnCu@SiO<sub>2</sub> microspheres is important for their long-term application. Since SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub>, SnZn<sub>0.04</sub>Cu<sub>0.02</sub>@SiO<sub>2</sub>, and SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres show similar phase change properties despite having different amounts of Cu, the thermal cycling stability of all three samples is investigated by measuring their phase change properties after repeated heating-cooling cycles between 200 and 250 °C. Figure 8a displays the DSC curves of the SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres after being subjected to different numbers of thermal cycles. The plot of both the undercooling and the heat of fusion or solidification as a function of the number of thermal

cycles is shown in Figure 8b (note that the heat of solidification is calculated based on the first exothermic peak if there are two or more peaks appearing in the solidification process). It is clear from Figure 8 that, although the freezing peak gradually shifts to the right and thus the undercooling decreases slightly as the number of thermal cycles increases to 30, there is no remarkable change in both heat of fusion and heat of solidification with the latter being almost equal to the former if the number of thermal cycles is not more than 30. When the number of thermal cycles reaches 40 or above, however, a new broad exothermic peak appears in the low-temperature region (indicated by a star in the insets of Figure 8a) and thus results in an obvious decrease in heat of solidification that is calculated on the first exothermic peak (see Figure 8b). These observations suggest that  $\text{SnZn}_{0.04}\text{Cu}_{0.015}@SiO_2$  microspheres become thermally unstable after 40 thermal cycles.

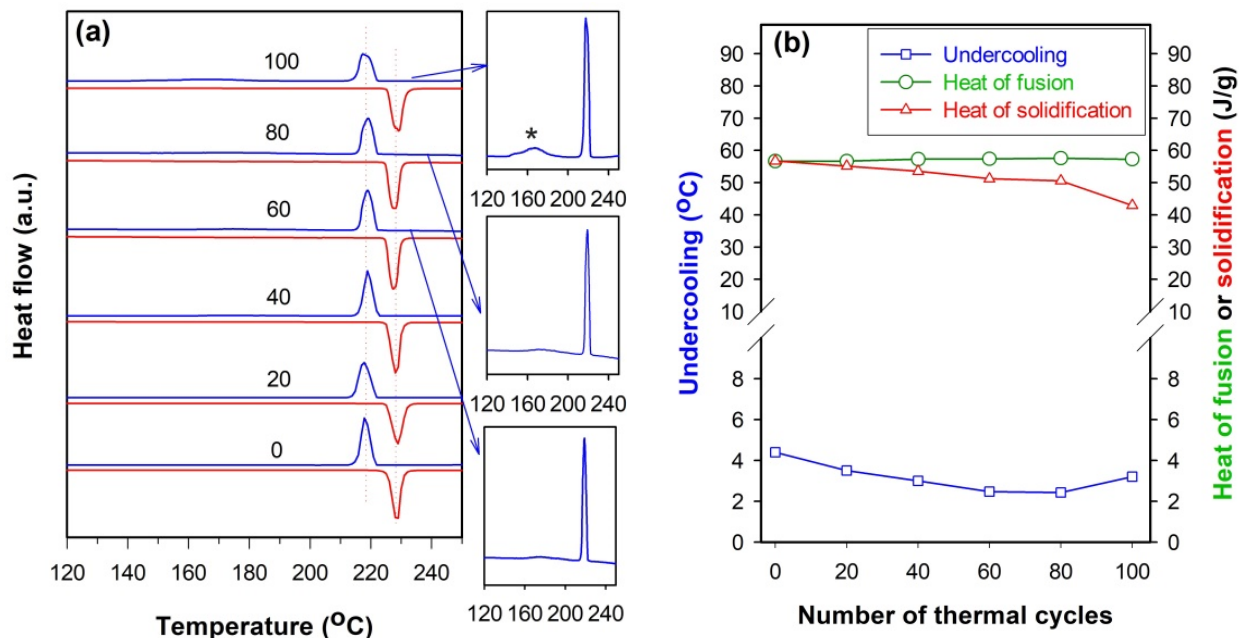


**Figure 8.** (a) DSC curves of  $\text{SnZn}_{0.04}\text{Cu}_{0.015}@SiO_2$  microspheres (encapsulation times = 3) after different numbers of thermal cycles and (b) plot of both the undercooling and latent heat vs. the number of thermal cycles.

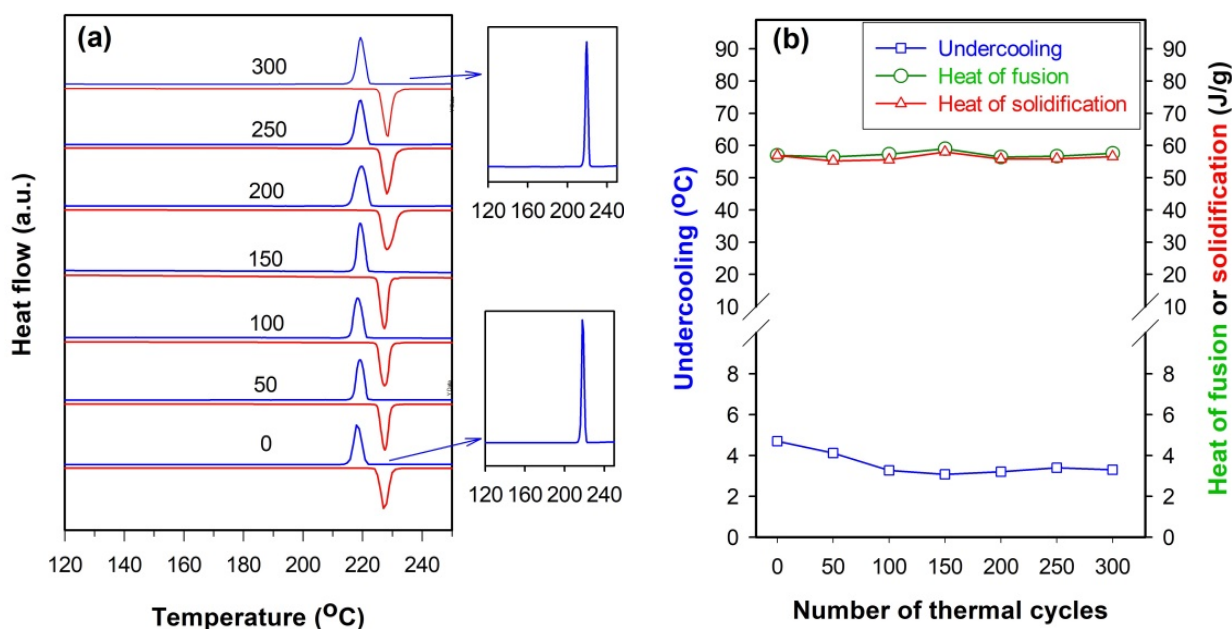
In the thermal cycling test of the  $\text{SnZn}_{0.04}\text{Cu}_{0.02}@SiO_2$  microspheres, a similar thermal instability can be observed (see Figure 9). However, the broad exothermic peak is observed clearly only when the number of thermal cycles reaches more than 80 (see insets of Figure 9a). This indicates that the  $\text{SnZn}_{0.04}\text{Cu}_{0.02}@SiO_2$  microspheres are more thermally stable than the  $\text{SnZn}_{0.04}\text{Cu}_{0.015}@SiO_2$  microspheres and a rise in the amount of Cu can improve the thermal cycling stability of  $\text{SnZnCu}@SiO_2$  microspheres. The positive effect of the amount of Cu on the thermal cycling stability of  $\text{SnZnCu}@SiO_2$  microspheres is further supported by the result obtained from the  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@SiO_2$  microspheres. As shown in Figure 10, except that the undercooling decreases slightly as the number of thermal cycles increases to 150, there is almost no change in heat of fusion or solidification of  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@SiO_2$  microspheres even after 300 thermal cycles. Similar to the untreated sample, no broad exothermic peak appears in the solidification curve after 300 thermal cycles (see insets of Figure 10a), hinting that the thermal cycling stability of the  $\text{SnZnCu}@SiO_2$  microspheres can be remarkably improved as the amount of Cu increases to about 3.0 at.%.

The high thermal stability of the  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@SiO_2$  microspheres, as well as their very low undercooling and narrow freezing/melting peak width, suggests that they should be a promising PCM for latent heat storage. Table 1 gives a comparison of the properties between  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@SiO_2$  microspheres and some PCMs with a melting point ranging from 220 to 240 °C, including encapsulated Sn and some nitrate salt-based PCMs. Besides having very poor thermal conductivity [4], it is clear from Table 1 that the latent heat of

fusion on a volume basis of the nitrate-based PCMs with a melting point close to that of Sn is also less than that of  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@\text{SiO}_2$  microspheres, giving  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@\text{SiO}_2$  microspheres an edge over those nitrate salts as PCMs used in the case where a limited room is available for PCMs.



**Figure 9.** (a) DSC curves of  $\text{SnZn}_{0.04}\text{Cu}_{0.02}@SiO_2$  microspheres (encapsulation times = 3) after different numbers of thermal cycles and (b) plot of both the undercooling and latent heat vs. the number of thermal cycles.



**Figure 10.** (a) DSC curves of  $\text{SnZn}_{0.04}\text{Cu}_{0.03}@SiO_2$  microspheres (encapsulation times = 3) after different numbers of thermal cycles and (b) plot of both the undercooling and latent heat vs. the number of thermal cycles.

**Table 1.** A comparison between the properties of SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres and some PCMs with a melting peak temperature ranging from 220 to 240 °C.

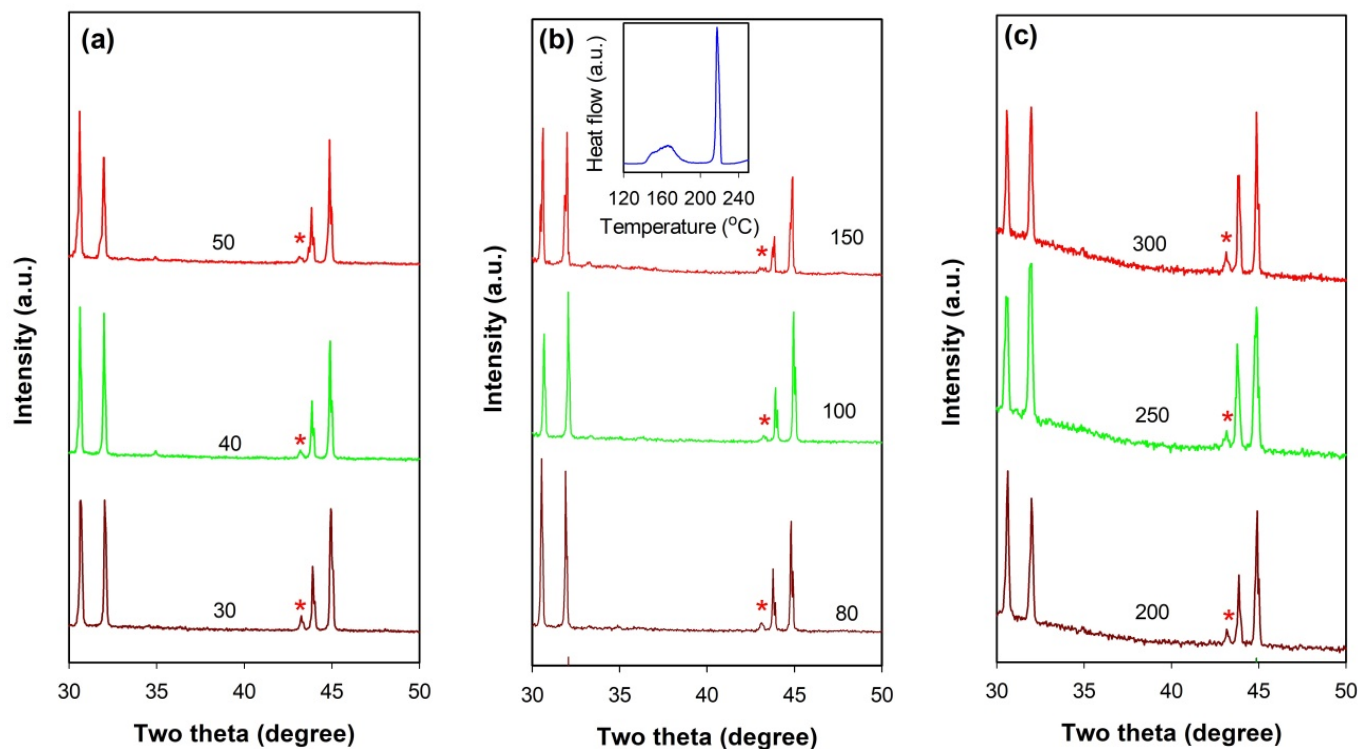
| No. | Phase Change Material  | Melting Peak Temperature/°C | Undercooling/°C | Heat of Fusion on a Mass Basis (J/g) | Heat of Fusion on a Volume Basis (J/cm <sup>3</sup> ) | Ref.      |
|-----|--|-----------------------------|-----------------|--------------------------------------|---|-----------|
| 1   | Sn@Al <sub>2</sub> O <sub>3</sub> -1600                                    | 233.6                       | ~78             | 46.01                                | unknown   | [16]      |
| 2   | Sn@ SiO <sub>2</sub> microspheres  | 235.0                       | 76.2            | 57.8                                 | unknown   | [14]      |
| 3   | Ca(NO <sub>3</sub> ) <sub>2</sub> /NaNO <sub>3</sub><br>(30:70 mol.%)      | ~230                        | unknown         | 135.8                                | 269 <sup>a</sup>                                      | [33]      |
| 4   | KNO <sub>3</sub> /NaNO <sub>3</sub><br>(50:50 mol.%)                       | 226.0                       | ~5              | 106.3                                | 207 <sup>a</sup>                                      | [34]      |
| 5   | KNO <sub>3</sub> /NaNO <sub>3</sub><br>(50:50 mol.%) / SiC (30 wt.%)       | 226.7                       | ~5              | 72.8                                 | <207 <sup>a</sup>                                     | [34]      |
| 6   | H220   | 220                         | unknown         | 100                                  | 200   | [4]       |
| 7   | NaNO <sub>3</sub> /KNO <sub>3</sub> (60:40 wt.%)                           | 223.2                       | unknown         | 142.2                                | 275 <sup>a</sup>                                      | [35]      |
| 8   | NaNO <sub>3</sub> /KNO <sub>3</sub><br>(60:40 wt.%) / graphite<br>(1 wt.%) | 224.8                       | unknown         | 128.4                                | <275 <sup>a</sup>                                     | [35]      |
| 9   | SnZn <sub>0.04</sub> Cu <sub>0.03</sub> @SiO <sub>2</sub><br>microspheres  | 229.2                       | 4.3             | 57.9                                 | 330 <sup>b</sup>                                      | This work |

<sup>a</sup> Estimated based on the density data at 493 K found in the Refs. [36,37]. <sup>b</sup> The density measured is about 5.7 g/cm<sup>3</sup> at 25 °C.

As has been mentioned above, a new exothermic peak normally appears in the solidification process when the SnZnCu@SiO<sub>2</sub> microspheres are not thermally stable. Compared with the first exothermic peak, this peak is much broader and appears in the lower temperature region. This feature demonstrates that the solidification of some liquid metal needs high undercooling and occurs slowly, which is similar to the solidification process in the SnCu<sub>0.015</sub>@SiO<sub>2</sub> (see Figure 6a) or SnCu<sub>0.02</sub>@SiO<sub>2</sub> microspheres (see Figure S3 in Supplementary Materials). Since the Cu<sub>5</sub>Zn<sub>8</sub> phase contributes significantly to both much lower undercooling and narrower freezing peak of SnZnCu@SiO<sub>2</sub> microspheres compared to those of SnCu@SiO<sub>2</sub> microspheres, it is speculated that the appearance of a broad exothermic peak indicates a possibility of the decomposition of this phase, which has been observed in the soldered Sn–Ag–Zn/Cu interface [38]. Therefore, the Cu<sub>5</sub>Zn<sub>8</sub> phase was investigated by XRD to understand the origin of thermal instability observed in the SnCuZn@SiO<sub>2</sub> microspheres after thermal cycling.

Figure 11 presents a comparison between the XRD patterns of thermally stable and unstable SnZnCu@SiO<sub>2</sub> microspheres after thermal cycling. For all three types of SnZnCu@SiO<sub>2</sub> microspheres, whether thermally stable or unstable, the Cu<sub>5</sub>Zn<sub>8</sub> phase can be found in their XRD patterns (indicated by a red star). However, an obvious decrease in diffraction intensity of this phase is observed in the SnZn<sub>0.04</sub>Cu<sub>0.015</sub>@SiO<sub>2</sub> microspheres after 40 or 50 thermal cycles compared to those after 30 thermal cycles (Figure 11a). The crystal size of the Cu<sub>5</sub>Zn<sub>8</sub> phase estimated by Scherrer's equation is reduced from about 50 nm (after 30 thermal cycles) to 30 nm (after 50 thermal cycles). A similar phenomenon can also be observed in the SnZn<sub>0.04</sub>Cu<sub>0.02</sub>@SiO<sub>2</sub> microspheres after 100 thermal cycles (Figure 11b), especially the sample subjected to another 50 thermal cycles (namely 100 thermal cycles totally) which becomes more unstable as indicated by an obvious rise in the peak intensity of the second exothermic peak in the DSC curve (see inset of Figure 11b). The crystal size of the Cu<sub>5</sub>Zn<sub>8</sub> phase is reduced from about 45 nm (after 80 thermal cycles) to 20 nm (after 150 thermal cycles). However, this phenomenon cannot be observed in the SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres after 300 thermal cycles (Figure 11c). These observations imply the occurrence of the decomposition of Cu<sub>5</sub>Zn<sub>8</sub>, and the thermal cycling stability of SnZnCu@SiO<sub>2</sub> microspheres is strongly related to this phase. The fact that the decomposition of Cu<sub>5</sub>Zn<sub>8</sub> does not occur in the SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> microspheres after 300 thermal cycles demonstrates that an increase in the amount of Cu can improve its stability. This can be understood from the thermodynamic point of view. The decomposition of Cu<sub>5</sub>Zn<sub>8</sub> during thermal cycling should take place at a temperature where Sn is liquefied. When the

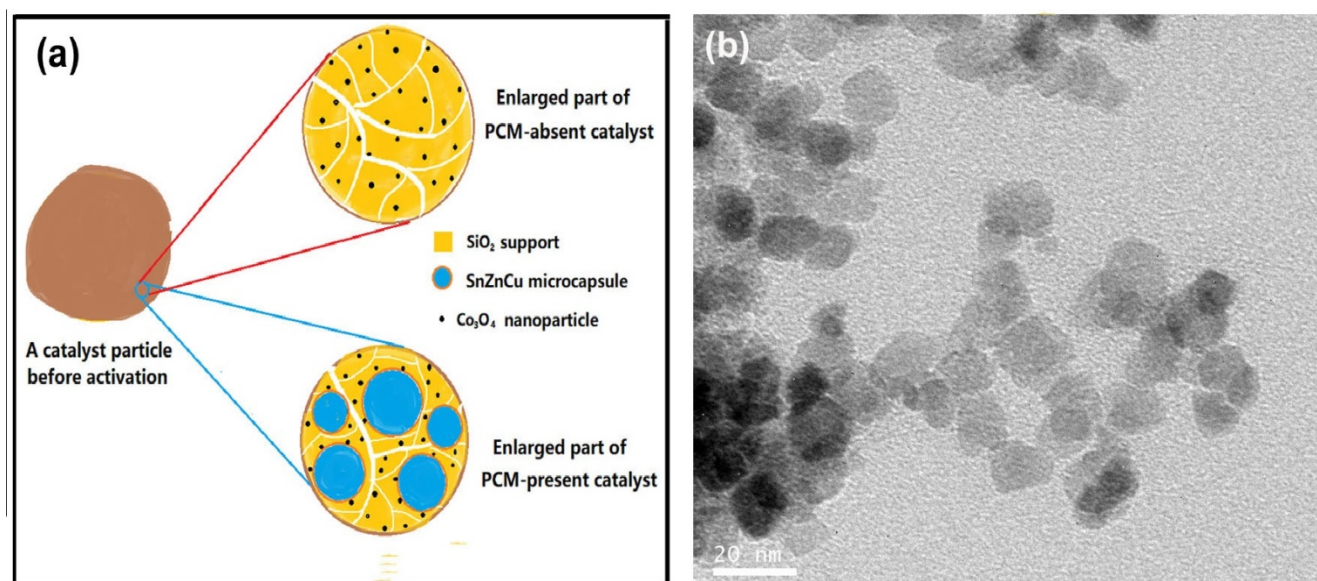
decomposition of  $\text{Cu}_5\text{Zn}_8$  occurs, the Cu atoms formed will be highly dispersed into the liquid Sn phase as suggested by the above XRD result that no Cu phase is detected even at room temperature. Thermodynamically, therefore, an increase in the amount of Cu present in the liquid Sn phase is unfavorable for the decomposition of  $\text{Cu}_5\text{Zn}_8$ .



**Figure 11.** XRD patterns of  $\text{SnZnCu@SiO}_2$  microspheres (encapsulation times = 3) after different numbers of thermal cycles: (a)  $\text{SnZn}_{0.04}\text{Cu}_{0.015}\text{@SiO}_2$ , (b)  $\text{SnZn}_{0.04}\text{Cu}_{0.02}\text{@SiO}_2$ , and (c)  $\text{SnZn}_{0.04}\text{Cu}_{0.03}\text{@SiO}_2$ . The  $\text{Cu}_5\text{Zn}_8$  phase is indicated by a red star. The inset of Figure 10b is the DSC curve of the  $\text{SnZn}_{0.04}\text{Cu}_{0.02}\text{@SiO}_2$  microspheres after 150 thermal cycles.

#### 2.4. Application of $\text{SnZn}_{0.04}\text{Cu}_{0.03}\text{@SiO}_2$ Microspheres in Fischer–Tropsch Synthesis for Stabilizing the Temperature of the Catalyst Bed

Fischer–Tropsch synthesis is an important process for converting coal or natural gas to liquid fuels. As a highly exothermic catalytic reaction ( $\Delta H = -165 \text{ kJ/mol}$  of CO) [39], efficient heat removal from the packed bed is critical because an undesirable temperature rise may lead to catalyst deactivation, negative effect on product selectivity, and even thermal runaway. To facilitate the heat transfer across the catalyst bed, improving the thermal conductivity of the catalysts, e.g., depositing the catalyst on monolith [40], growing the catalyst on metal foam [41], and entrapping metal microfiber into the catalyst [18], is a common strategy. In contrast, this work presents a tentative study on the possibility of using metal-based PCMs to improve the thermal stability of the catalyst bed by embedding  $\text{SnZn}_{0.04}\text{Cu}_{0.03}\text{@SiO}_2$  microspheres into the  $\text{Co/SiO}_2$  catalyst. Figure 12a illustrates the structural difference between PCM-absent and PCM-present catalysts before activation. To make a reasonable comparison between PCM-absent and PCM-present catalysts, the pre-synthesized  $\text{Co}_3\text{O}_4$  nanoparticles (see Figure 12b), rather soluble cobalt salts, are used as the precursor to ensure that the size of active component Co in two catalysts is the same. In addition, the amount of Co loaded in the packed bed in two cases should be as close as possible.

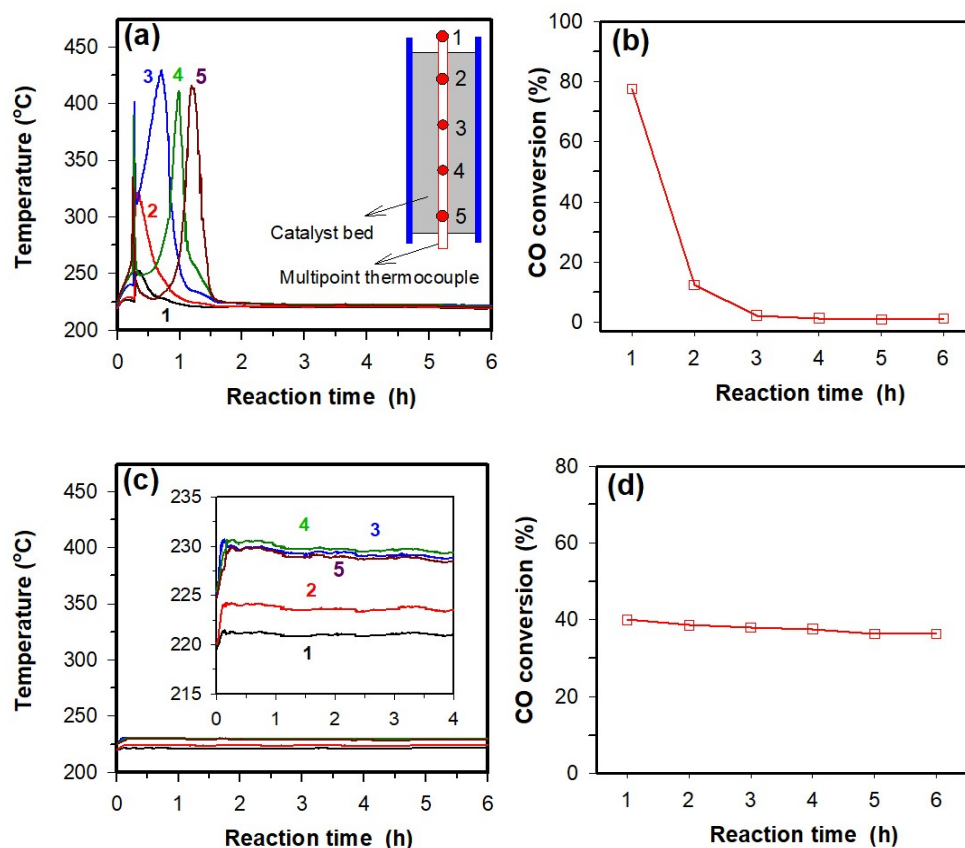


**Figure 12.** (a) Illustration for the structural difference between PCM-absent and PCM-present Co/SiO<sub>2</sub> catalysts before activation and (b) TEM image of Co<sub>3</sub>O<sub>4</sub> nanoparticles.

Figure 13 presents the temperature profiles at the centerline of the packed beds of two catalysts measured by a multi-point thermocouple (locations of thermocouple no. 1–5 is shown in the inset of Figure 13a) and the CO conversions over two catalysts. For the PCM-absent Co/SiO<sub>2</sub> catalyst (Figure 13a), the temperature of the catalyst bed increases rapidly at the beginning and hot spots with an amplitude of 100–200 °C can be observed. The hot spot is initially located at the top of the catalyst bed and then moves in a downstream direction, probably due to loss of catalyst activity with time. The maximum temperature difference in the axial direction is about 200 °C. After about 1.5 h, the catalyst bed reaches a steady temperature distribution with a negligible temperature difference in the axial direction, suggesting that the catalyst should be totally deactivated. This is confirmed by the data of catalytic activity measured (Figure 13b), where the conversion of CO is reduced from about 80% to 1% when the catalyst bed reaches a steady temperature distribution. The rapid deactivation of the catalyst should be associated with the high temperature of the hot spot or thermal runaway which may accelerate re-oxidation [18], carbon deposition [42], or sintering of cobalt nanocrystals [43]. As shown in the inset of Figure 13c, however, the temperature profiles at the centerline of the packed bed of the PCM-present Co/SiO<sub>2</sub> catalyst are quite different from that of PCM-absent Co/SiO<sub>2</sub> catalyst. Hot spots can be suppressed and thus no thermal runaway is found, and the catalyst bed almost reaches a steady temperature distribution during the startup period. The maximum temperature difference in the axial direction is about 6.5 °C (see inset of Figure 13c), much lower than the value of about 200 °C observed in the PCM-absent Co/SiO<sub>2</sub> catalyst bed. As a result, deactivation of the catalyst due to thermal runaway is not found and the CO conversion remains in a steady state with a value close to 40% (Figure 13d). These observations demonstrate that the presence of Sn–Zn–Cu PCM in the catalyst can greatly improve the thermal stability of the catalyst bed in Fischer–Tropsch synthesis.

The positive effect on the thermal stability of the catalyst bed observed in the PCM-present Co/SiO<sub>2</sub> catalyst should be related to the fact that Sn–Zn–Cu PCM not only owns a much higher thermal conductivity than the amorphous SiO<sub>2</sub> but also has the ability to store thermal energy released by the reaction. First, because the thermal conductivities of both Cu and Zn (about 386 and 113 W·m<sup>−1</sup>·K<sup>−1</sup> at 293 K, respectively [19]) are higher than that of Sn (about 67 W·m<sup>−1</sup>·K<sup>−1</sup> at 293 K), the Sn–Zn–Cu PCM should have a thermal conductivity higher than that of Sn. The much higher thermal conductivity of Sn–Zn–Cu PCM compared to the amorphous SiO<sub>2</sub> (about 1 W·m<sup>−1</sup>·K<sup>−1</sup> at 300 K [44]) allows the

bed of the PCM-present catalyst a high heat removal rate (via heat transfer through the walls), which is critical for achieving a steady catalyst bed temperature distribution and avoiding thermal runaway in the case where high CO conversion is high (namely high heat generation rate). Second, since Sn–Zn–Cu PCM can absorb the heat of reaction via solid–liquid phase change when the temperature of catalyst bed reaches its melting point, the presence of PCM can help to suppress the formation of hot spots, especially the one caused by the unexpected, temporary variation in the operating conditions. In addition, since the Sn–Zn–Cu PCM can release the absorbed heat via liquid–solid phase transition, the use of a PCM-containing catalyst may also reduce the electric heating time of the reactor and thus save energy if the PID controlled reaction temperature is set slightly below the melting point of PCM.



**Figure 13.** Temperature profiles at the centerline of the packed beds of PCM-absent (a) and PCM-present (c) Co/SiO<sub>2</sub> catalysts measured by a multi-point thermocouple (locations of thermocouple no. 1–5 are shown in the inset) and CO conversion as a function of reaction time over PCM-absent (b) and PCM-present (d) Co/SiO<sub>2</sub> catalysts. Inset in (c) is a magnified version of the plot of temperature vs. reaction time (from 0 to 4 h).

### 3. Materials and Methods

#### 3.1. Materials and Chemicals

Except carboxymethylcellulose sodium (Chemical pure, 300–800 mPa·s), all other chemicals were of analytical grade and used as received. Except for Sn ( $\geq 99.5\%$ , MCLean Biochemical Technology Co., Ltd., Shanghai, China), ethanol (purchased from Anhui Ante Food Co., Ltd., Suzhou, China), ethylenediamine (purchased from Shanghai Wulian Chemical Co., Ltd., Shanghai, China), Cu(OH)<sub>2</sub> (purchased from Shanghai Zhenxin Reagent Factory, Shanghai, China), and carboxymethylcellulose sodium (Sinopharm Chemical Reagent Co., Ltd., Shanghai, China), all other reagents, including Zn ( $\geq 99.9\%$ ), were obtained from Aladdin Chemical Reagent Co., Ltd. (Shanghai, China). Cu nanowires (CuNWs) used were prepared via a cheap and environmentally friendly method developed

by the authors [45], and  $\text{Co}_3\text{O}_4$  nanoparticles were prepared by a method reported by Dong et al. [46].

### 3.2. Preparation of $\text{SnZnCu}@SiO_2$ Microspheres and PCM-Present $\text{Co/SiO}_2$ Catalyst

Preparation of  $\text{SnZnCu}$  microspheres by a molten salt-based metal emulsion method. (1) Synthesis of bulk  $\text{SnZnCu}$ . About 3.0 g of Sn and a given amount of CuNWs were put into a corundum tube filled with Ar gas. Then both Sn and CuNWs were covered by about 22.1 g of LiCl–KCl–CsCl eutectic (54.4 wt.% CsCl, 30.3 wt.% LiCl, and 15.3 wt.% KCl), and the tube was heated to 750 °C in about 15 min. After stirring at 750 °C for 20 min, the liquid metals were cooled down to 600 °C and then a given amount of Zn powder was added under the Ar gas protection. After being kept at 600 °C for 1 h under stirring, the liquid metals were rapidly cooled down by dumping them into an Ar-filled steel container which was put in an ice-water bath. (2) Ultrasonically dispersing bulk  $\text{SnZnCu}$  into molten salts. The above cooled mixture was transferred into a quartz tube and then heated to 600 °C under argon gas protection. After the LiCl–KCl–CsCl eutectic was molten (about 10 min), the mixture was cooled to 380 °C and then emulsified via ultrasonic cavitation (20 KHz, 960 W, 3 s interval between every 2 s duty) for about 5 min with the distance between the sonotrode tip ( $\varnothing 20$  mm) and the molten salt–metal interface being about 8 mm. (3) Rapidly cooling the emulsion and removing the salts. The metal emulsion was quickly cooled to room temperature by dumping them into an Ar-filled steel container which was put in an ice-water bath. The chloride salts were separated from the metals by dissolving them in deionized water. After removal of the salts, the solid product was washed with deionized water and then dried in a vacuum at 65 °C for 3 h. For comparison, Sn and  $\text{SnCu}$  microspheres were also prepared by such a molten salt-based metal emulsion method. A total 11 samples were prepared and the nominal atomic concentrations of Zn or/and Cu are summarized in Table 2.

**Table 2.** Nominal atomic concentration of Zn or/and Cu in the samples.

| Sample No. | Sample Code                           | Nominal Atomic Concentration of Zn or/and Cu |           |
|------------|---------------------------------------|--|-----------|
|            |                                       | Zn (at.%)                                    | Cu (at.%) |
| 1          | Sn                                    | 0  | 0         |
| 2          | $\text{SnCu}_{0.015}$                 | 0  | 1.5       |
| 3          | $\text{SnCu}_{0.02}$                  | 0  | 2.0       |
| 4          | $\text{SnCu}_{0.03}$                  | 0  | 3.0       |
| 5          | $\text{SnZn}_{0.04}$                  | 4.0  | 0         |
| 6          | $\text{SnZn}_{0.03}\text{Cu}_{0.015}$ | 3.0  | 1.5       |
| 7          | $\text{SnZn}_{0.04}\text{Cu}_{0.015}$ | 4.0  | 1.5       |
| 8          | $\text{SnZn}_{0.05}\text{Cu}_{0.015}$ | 5.0  | 1.5       |
| 9          | $\text{SnZn}_{0.04}\text{Cu}_{0.02}$  | 4.0  | 2.0       |
| 10         | $\text{SnZn}_{0.04}\text{Cu}_{0.03}$  | 4.0  | 3.0       |
| 11         | $\text{SnZn}_{0.04}\text{Cu}_{0.04}$  | 4.0  | 4.0       |

Ultrasound-assisted encapsulation via a sol–gel method. Typically, about 0.50 g metal microparticles, 0.12 mL of  $\text{NH}_4\text{F}$  aqueous solution (containing about 0.0008 g  $\text{NH}_4\text{F}$ ), 0.48 mL glycerol, and about 0.016 g Triton X-100 were added into a plastic tube, and the mixture was stirred until blended. A total of 10 mL cyclohexane was added into the formed slurry, and then the tube was placed into a water bath to prevent overheating due to ultrasonic cavitation. The Sn-containing slurry was dispersed into cyclohexane by probe sonication (duty ratio 3/5, sonotrode tip diameter = 10 mm, the distance between the sonotrode tip and the cyclohexane–slurry interface is ~8 mm) for 2 min. After dispersing, about 0.6 mL of tetraethyl orthosilicate (TEOS) was added dropwise into the tube under ultrasonic cavitation in 2 min. To complete the hydrolysis–condensation reactions of TEOS, the ultrasonic cavitation further lasted for 30 min. After the reaction, the solid product was collected by centrifugation (5000 rpm). The obtained product was then washed with water and ethanol and dried under a vacuum.



Preparation of the PCM-present Co/SiO<sub>2</sub> catalyst. Typically, about 0.95 g of Co<sub>3</sub>O<sub>4</sub> was ultrasonically dispersed into about 5 mL of ethanol in an ice-water bath (600 W, 3 s interval between every 2 s duty). Then, about 5 mL of PCM microcapsules were added to the above mixture. After sonication for several minutes, 1 mL H<sub>2</sub>O, 5 mL TEOS, and 0.6 mL aqueous ammonia (25 wt.%) were successively added. After 20 min of sonication, about 0.035 g of carboxymethylcellulose sodium was added under mechanical stirring. The mixture was further stirred for 5 h at a temperature of 50 °C and then cooled down to room temperature, dried at 80 °C for about 5 min to obtain a thick slurry. The slurry was shaped into catalyst particles of about 1 to 2 mm in diameter. Finally, the catalyst particles were dried at 80 °C for 3 h and calcined at 400 °C in N<sub>2</sub> for 4 h. For the sake of comparison, the PCM-absent Co/SiO<sub>2</sub> catalyst was also prepared by a similar procedure except that no PCM microcapsules were used and the amounts of TEOS, H<sub>2</sub>O, ethanol, and aqueous ammonia were doubled.

### 3.3. Thermal Cycling Test and Catalyst Testing

**Thermal cycling test.** The thermal cycling test of SiO<sub>2</sub>-encapsulated SnZnCu microspheres was performed in a quartz tub heated by a tubular electrical furnace. The sample of about 0.5 g was put into an alumina open crucible, and then the crucible was introduced into the quartz tube to conduct the experiments under an N<sub>2</sub> flux (20 mL/min). In each melting/solidification cycle, a heating/cooling rate of about 10 °C/min was applied between 200 and 250 °C, with isothermal steps of 10 min at minimum (200 °C) and maximum temperatures (250 °C). The sample was subjected to a given number of melting/solidification cycles. During the experiments, the cycling was interrupted after each consecutive 10, 20, or 50 thermal cycles depending on the sample, and the sample was taken out to measure its phase composition and phase change properties.

**Catalyst testing.** The catalysts were tested in a fixed bed reactor with a 0.63 m 316 L tube of 0.012 m in internal diameter. The outlet of the reactor was connected with a hot trap (150 °C) and a cold trap (0 °C). A thin sheath multi-point thermocouple with low axial thermal conductivity (Omega, 5 points, 25.4 mm separation intervals) was used to measure the temperatures in the catalyst beds at different heights. After in situ reduction of the catalyst at 400 °C for 10 h, the packed bed was cooled to the desired temperature. Then syngas with a H<sub>2</sub>/CO ratio of 2:1 was fed to the reactor at a pressure of 2 MPa (the space velocity is 2000 h<sup>-1</sup>). The outlet gas after the cold trap was measured online by gas chromatography (GC, Fuli 9790, Zhejiang Fuli Analytical Instrument Co., Ltd., Taizhou, China) with two packed columns (GDX-502 and TDX-01, Lanzhou Zhongke Kaidi Chemical New Technology Co., Ltd., Lanzhou, China) for analysis of H<sub>2</sub>, CO, CO<sub>2</sub>, and CH<sub>4</sub> concentrations (nitrogen as the internal standard) by a TCD detector (Zhejiang Fuli Analytical Instrument Co., Ltd., Taizhou, China) and a capillary column (PLOT AL<sub>2</sub>O<sub>3</sub>) for analysis of uncondensed C<sub>2</sub>-C<sub>10</sub> in the residual gas by an FID detector (Zhejiang Fuli Analytical Instrument Co., Ltd., Taizhou, China).

### 3.4. Characterization

The morphology of the samples was examined using a scanning electron microscope (SEM, Hitachi S-4700, Hitachi High-Technologies Corporation, Tokyo, Japan) operating at 15 kV. The phase composition was analyzed by X-ray diffraction (XRD), which was performed on a Thermo ARL XTRA X-ray diffractometer (Thermo Fisher Scientific, Waltham, MA, USA) using Cu K $\alpha$  X-ray source. The phase composition was analyzed by the Jade software (Version 5, Materials Data, Livermore, CA, USA) with a PDF2-2004 databank. The microstructure investigations were performed with a Tecnai G2 F30 S-Twin transmission electron microscopy (TEM) operating at 300 kV or an FEI Talos-S transmission electron microscope (Thermo Fisher Scientific, Waltham, MA, USA) operating at 200 kV. Measurements of solid-liquid phase change temperatures and latent heat of PCMs were carried out by using a differential scanning calorimeter instrument (DSC, Mettler Toledo, Zurich,

Switzerland) or NETZSCH DSC 200F3 (NETZSCH-Gerätebau GmbH, Selb, Germany) under nitrogen atmosphere and at a heating/cooling rate of 10 °C/min.

#### 4. Conclusions

In summary, well-shaped SnZnCu@SiO<sub>2</sub> microspheres can be prepared by combining a molten salt-based metal emulsion method and a sol-gel approach. The uniform SiO<sub>2</sub> layer can prevent the leakage of liquid metals at high temperatures but cannot induce heterogeneous nucleation that may significantly reduce the undercooling of Sn microspheres. However, the addition of a suitable amount of Cu (1.5–3.0 at.%) and Zn (4.0 at.%) into Sn microspheres can achieve a type of SnZnCu@SiO<sub>2</sub> microspheres with very low undercooling (<5.0 °C at a ramp rate of 10 °C) and a narrow freezing/melting peak width, which should be a result of the formation of both Sn–Zn–Cu ternary eutectic and metastable phase Cu<sub>5</sub>Zn<sub>8</sub>. A rise in the amount of Cu has a positive effect on the thermal cycling stability of SnZnCu@SiO<sub>2</sub> microspheres, and SnZn<sub>0.04</sub>Cu<sub>0.03</sub>@SiO<sub>2</sub> is highly stable. The thermal cycling stability of SnZnCu@SiO<sub>2</sub> microspheres is governed by the stability of the Cu<sub>5</sub>Zn<sub>8</sub> phase, and thermodynamically, an increase in the amount of Cu is unfavorable for its decomposition. Measurement of both the catalyst bed temperature and catalytic activity for Fischer–Tropsch synthesis of the Co/SiO<sub>2</sub> catalysts with or without PCM reveals that the presence of SnZn<sub>0.04</sub>Cu<sub>0.03</sub> PCM, which not only owns a much higher thermal conductivity than the amorphous SiO<sub>2</sub> but also has the ability to store the thermal energy released by the reaction, can significantly reduce the temperature gradient in the catalyst bed by suppressing the formation of hot spots or thermal runaway and thus prevent rapid deactivation of Co catalyst that occurs in the PCM-absent Co/SiO<sub>2</sub> catalyst.

**Supplementary Materials:** The following are available online at <https://www.mdpi.com/article/10.3390/catal12020205/s1>, Figure S1: SEM images of Cu nanowires before and after calcinated for 30 min in Ar atmosphere at different temperatures, Figure S2: XRD patterns of SnCu<sub>0.02</sub> and SnCu<sub>0.03</sub> microspheres. Figure S3: DSC curves of SnCu<sub>0.02</sub>@SiO<sub>2</sub> and SnCu<sub>0.03</sub>@SiO<sub>2</sub> microspheres.

**Author Contributions:** H.T. and Z.L. conceived and designed the experiments; X.Z., Y.Y. and J.L. performed the experiments; Y.Z. helped with the characterization of the samples; H.T., X.Z. and Z.L. wrote the paper. All authors have read and agreed to the published version of the manuscript.

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